

2Gb DDR3 SDRAM

Lead-Free&Halogen-Free

(RoHS Compliant)

H5TQ2G83GFR-xxC

H5TQ2G63GFR-xxC

H5TQ2G83GFR-xxI

H5TQ2G63GFR-xxI

H5TQ2G83GFR-xxJ

H5TQ2G63GFR-xxJ

H5TQ2G83GFR-xxL

H5TQ2G63GFR-xxL

^{*} SK Hynix reserves the right to change products or specifications without notice.



Revision History

| Revision No. | History | Draft Date | Remark |
|--------------|-----------------------------------|------------|-------------|
| 0.1 | Preliminary version release | Mar. 2015 | Preliminary |
| 0.2 | PKG Dimension - Index mark Update | Apr. 2015 | 0.2 |
| 1.0 | IDD update | June.2015 | Page 24 |



Description

The H5TQ2G83GFR-xxC, H5TQ2G63GFR-xxC,H5TQ2G83GFR-xxI, H5TQ2G63GFR-xxI, H5TQ2G83GFR-xxL,H5TQ2G83GFR-xxL,H5TQ2G83GFR-xxJ,H5TQ2G83GFR-xxJ,H5TQ2G83GFR-xxJ,H5TQ2G83GFR-xxJ,H5TQ2G83GFR-xxJ,H5TQ2G83GFR-xxJ,H5TQ2G83GFR-xxJ,H5TQ2G83GFR-xxJ,H5TQ2G83GFR-xxJ,H5TQ2G83GFR-xxJ, H5TQ2G83GFR-xxI, H5TQ2G83GFR-xx

Device Features and Ordering Information

FEATURES

- VDD=VDDQ=1.5V +/- 0.075V
- Fully differential clock inputs (CK, CK) operation
- Differential Data Strobe (DQS, DQS)
- On chip DLL align DQ, DQS and DQS transition with CK transition
- DM masks write data-in at the both rising and falling edges of the data strobe
- All addresses and control inputs except data, data strobes and data masks latched on the rising edges of the clock
- Programmable CAS latency 5, 6, 7, 8, 9, 10, 11, 12, 13 and 14 supported
- Programmable additive latency 0, CL-1, and CL-2 supported
- Programmable CAS Write latency (CWL) = 5, 6, 7, 8
 9 and 10
- Programmable burst length 4/8 with both nibble sequential and interleave mode
- BL switch on the fly

- 8banks
- Average Refresh Cycle (Tcase 0 °C~95°C)
 - $-7.8 \mu s$ at $0^{\circ}C \sim 85 {\circ}C$
 - 3.9 µs at 85°C ~ 95 °C

Commercial Temperature(0°C ~ 95 °C)

Industrial Temperature(-40°C ~ 95 °C)

- JEDEC standard 78ball FBGA(x8), 96ball FBGA(x16)
- Driver strength selected by EMRS
- Dynamic On Die Termination supported
- · Asynchronous RESET pin supported
- · ZQ calibration supported
- TDQS (Termination Data Strobe) supported (x8 only)
- · Write Levelization supported
- 8 bit pre-fetch

^{*} This product in compliance with the RoHS directive.



ORDERING INFORMATION

| Part No. | Configuration | Power Consumption | Temperature | Package | |
|------------------|---------------|-----------------------|-------------|-------------|--|
| H5TQ2G83GFR-*xxC | | Normal Consumption | Commercial | | |
| H5TQ2G83GFR-*xxI | 256M x 8 | Normal Consumption | Industrial | 78ball FBGA | |
| H5TQ2G83GFR-*xxL | 230141 X 6 | Low Power Consumption | Commercial | 700ali FDGA | |
| H5TQ2G83GFR-*xxJ | | (IDD6 Only) | Industiral | | |
| H5TQ2G63GFR-*xxC | | Normal Consumption | Commercial | | |
| H5TQ2G63GFR-*xxI | 128M x 16 | Normal Consumption | Industrial | 96ball FBGA | |
| H5TQ2G63GFR-*xxL | | | Comercial | 90Dali FBGA | |
| H5TQ2G63GFR-*xxJ | | | Industrial | | |

^{*} xx means Speed Bin Grade

OPERATING FREQUENCY

| Speed Grade | Frequency [Mbps] | | | | | | | | | | Remark | | | |
|----------------|------------------|-----|------|------|------|------|------|------|------|------|--------------------|--|--|--|
| (Marking) | CL5 | CL6 | CL7 | CL8 | CL9 | CL10 | CL11 | CL12 | CL13 | CL14 | (CL-tRCD-tRP) | | | |
| -H9 | 667 | 800 | 1066 | 1066 | 1333 | 1333 | | | | | DDR3-1333 9-9-9 | | | |
| -PB | 667 | 800 | 1066 | 1066 | 1333 | 1333 | 1600 | | | | DDR3-1600 11-11-11 | | | |
| -RD | | 800 | 1066 | 1066 | 1333 | 1333 | 1600 | | 1866 | | DDR3-1866 13-13-13 | | | |
| -TE | | 800 | 1066 | 1066 | 1333 | 1333 | 1600 | | 1866 | 2133 | DDR3-2133 14-14-14 | | | |

^{*} Note1: In case of 1.5V P/N (H5TQ2G8(6)3GFR), -RDC covers Lower speed of -PBC and -H9C



x8 Package Ball out (Top view): 78ball FBGA Package

| | 1 | 2 | 3 | 4 | 5 | 6 | 7 | 8 | 9 | |
|---|--------|-------|-----|---|---|---|---------|--------|------|---|
| | | 1 | ı | 1 | | | | | | |
| Α | VSS | VDD | NC | | | | NU/TDQS | VSS | VDD | Α |
| В | VSS | VSSQ | DQ0 | | | | DM/TDQS | VSSQ | VDDQ | В |
| С | VDDQ | DQ2 | DQS | | | | DQ1 | DQ3 | VSSQ | С |
| D | VSSQ | DQ6 | DQS | | | | VDD | vss | VSSQ | D |
| E | VREFDQ | VDDQ | DQ4 | | | | DQ7 | DQ5 | VDDQ | E |
| F | NC | vss | RAS | | | | СК | vss | NC | F |
| G | ODT | VDD | CAS | | | | CK | VDD | CKE | G |
| Н | NC | cs | WE | | | | A10/AP | ZQ | NC | Н |
| J | VSS | BA0 | BA2 | | | | NC | VREFCA | vss | J |
| K | VDD | А3 | A0 | | | | A12/BC | BA1 | VDD | K |
| L | VSS | A5 | A2 | | | | A1 | A4 | vss | L |
| M | VDD | A7 | A9 | | | | A11 | A6 | VDD | М |
| N | VSS | RESET | A13 | | | | A14 | A8 | VSS | N |
| | | 1 | I | | | | ı | | | |
| | 1 | 2 | 3 | 4 | 5 | 6 | 7 | 8 | 9 | |

| | 1 2 3 | 7 8 9 |
|------------------|---|-------|
| A B C D | 000000000000000000000000000000000000000 | 000 |
| F | | 000 |
| G | 000 | 000 |
| Н | 000 | 000 |
| J | 000 | 000 |
| K | 000 | 000 |
| L | 000 | 000 |
| M | 000 | 000 |
| N | 000 | 000 |

(Top View: See the balls through the Package)

- O Populated ball
- + Ball not populated



x16 Package Ball out (Top view): 96ball FBGA Package

| | 1 | 2 | 3 | 4 | 5 | 6 | 7 | 8 | 9 | i) | |
|---|--------|-------|------|---|---|---|--------|--------|------|----|---|
| | | | | | | | | | | | |
| Α | VDDQ | DQU5 | DQU7 | | | | DQU4 | VDDQ | vss | | Α |
| В | VSSQ | VDD | vss | | | | DQSU | DQU6 | VSSQ | | В |
| С | VDDQ | DQU3 | DQU1 | | | | DQSU | DQU2 | VDDQ | | С |
| D | VSSQ | VDDQ | DMU | | | | DQU0 | VSSQ | VDD | | D |
| Е | VSS | VSSQ | DQL0 | | | | DML | VSSQ | VDDQ | | Е |
| F | VDDQ | DQL2 | DQSL | | | | DQL1 | DQL3 | VSSQ | | F |
| G | VSSQ | DQL6 | DQSL | | | | VDD | vss | VSSQ | | G |
| Н | VREFDQ | VDDQ | DQL4 | | | | DQL7 | DQL5 | VDDQ | | Н |
| J | NC | vss | RAS | | | | СК | vss | NC | | J |
| K | ODT | VDD | CAS | | | | CK | VDD | CKE | | K |
| L | NC | cs | WE | | | | A10/AP | ZQ | NC | | L |
| M | VSS | BA0 | BA2 | | | | NC | VREFCA | vss | | М |
| N | VDD | А3 | A0 | | | | A12/BC | BA1 | VDD | | N |
| Р | VSS | A5 | A2 | | | | A1 | A4 | vss | | Р |
| R | VDD | A7 | A9 | | | | A11 | A6 | VDD | | R |
| T | VSS | RESET | A13 | | | | NC | A8 | vss | | Т |
| | | 1 | 1 | | | | | 1 | | 1 | |
| | 1 | 2 | 3 | 4 | 5 | 6 | 7 | 8 | 9 | ì | |

| | 1 2 3 | 7 8 9 |
|---|-------|-------|
| Α | 000 | 000 |
| В | 000 | 000 |
| С | 000 | 000 |
| D | 000 | 000 |
| E | 000 | 000 |
| F | 000 | 000 |
| G | 000 | 000 |
| Н | 000 | 000 |
| J | 000 | 000 |
| K | 000 | 000 |
| L | 000 | 000 |
| M | 000 | 000 |
| N | 000 | 000 |
| Р | 000 | 000 |
| R | 000 | 000 |
| T | 000 | 000 |

(Top View: See the balls through the Package)

- O Populated ball
- + Ball not populated



Pin Functional Description

| Symbol | Туре | Function |
|--------------------------------------|-------|--|
| CK, CK | Input | Clock: CK and $\overline{\text{CK}}$ are differential clock inputs. All address and control input signals are sampled on the crossing of the positive edge of CK and negative edge of $\overline{\text{CK}}$. |
| CKE, (CKE0), (CKE1) | Input | Clock Enable: CKE HIGH activates, and CKE Low deactivates, internal clock signals and device input buffers and output drivers. Taking CKE Low provides Precharge Power-Down and Self-Refresh operation (all banks idle), or Active Power-Down (row Active in any bank). CKE is asynchronous for Self-Refresh exit. After VREFCA and VREFDQ have become stable during the power on and initialization sequence, they must be maintained during all operations (including Self-Refresh). CKE must be maintained high throughout read and write accesses. Input buffers, excluding CK, $\overline{\text{CK}}$, ODT and CKE, are disabled during power-down. Input buffers, excluding CKE, are disabled during Self-Refresh. |
| CS, (CS0), (CS1), (CS2), (CS3) | Input | Chip Select: All commands are masked when \overline{CS} is registered HIGH. \overline{CS} provides for external Rank selection on systems with multiple Ranks. \overline{CS} is considered part of the command code. |
| ODT, (ODT0), (ODT1) | Input | On Die Termination: ODT (registered HIGH) enables termination resistance internal to the DDR3 SDRAM. When enabled, ODT is only applied to each DQ, DQS, \overline{DQS} and DM/TDQS, NU/TDQS (When TDQS is enabled via Mode Register A11=1 in MR1) signal for x4/x8 configurations. For x16 configuration, ODT is applied to each DQ, DQSU, \overline{DQSU} , DQSL, DQSL, DMU, and DML signal. The ODT pin will be ignored if MR1 is programmed to disable ODT. |
| RAS. CAS. WE | Input | Command Inputs: \overline{RAS} , \overline{CAS} and \overline{WE} (along with \overline{CS}) define the command being entered. |
| DM, (DMU), (DML) | Input | Input Data Mask: DM is an input mask signal for write data. Input data is masked when DM is sampled HIGH coincident with that input data during a Write access. DM is sampled on both edges of DQS. For x8 device, the function of DM or TDQS/TDQS is enabled by Mode Register A11 setting in MR1. |
| BA0 - BA2 | Input | Bank Address Inputs: BA0 - BA2 define to which bank an Active, Read, Write or Precharge command is being applied. Bank address also determines if the mode register or extended mode register is to be accessed during a MRS cycle. |
| A0 - A15 | Input | Address Inputs: Provide the row address for Active commands and the column address for Read/Write commands to select one location out of the memory array in the respective bank. (A10/AP and A12/BC have additional functions, see below). The address inputs also provide the op-code during Mode Register Set commands. |
| A10 / AP | Input | Auto-precharge: A10 is sampled during Read/Write commands to determine whether Autoprecharge should be performed to the accessed bank after the Read/Write operation. (HIGH: Autoprecharge; LOW: no Autoprecharge).A10 is sampled during a Precharge command to determine whether the Precharge applies to one bank (A10 LOW) or all banks (A10 HIGH). If only one bank is to be precharged, the bank is selected by bank addresses. |
| A12 / BC | Input | Burst Chop: A12 / \overline{BC} is sampled during Read and Write commands to determine if burst chop (on-the-fly) will be performed. (HIGH, no burst chop; LOW: burst chopped). See command truth table for details. |



| Symbol | Туре | Function |
|---|-------------------|--|
| RESET | Input | Active Low Asynchronous Reset: Reset is active when RESET is LOW, and inactive when RESET is HIGH. RESET must be HIGH during normal operation. RESET is a CMOS rail-to-rail signal with DC high and low at 80% and 20% of VDD, i.e. 1.20V for DC high and 0.30V for DC low. |
| DQ | Input / Output | Data Input/ Output: Bi-directional data bus. |
| DQU, DQL, DQS, DQS, DQSU, DQSU, DQSL, DQSL | Input / Output | Data Strobe: output with read data, input with write data. Edge-aligned with read data, centered in write data. The data strobe DQS, DQSL, and DQSU are paired with differential signals DQS, DQSL, and DQSU, respectively, to provide differential pair signaling to the system during reads and writes. DDR3 SDRAM supports differential data strobe only and does not support single-ended. |
| TDQS, TDQS | Output | Termination Data Strobe: TDQS/ $\overline{\text{TDQS}}$ is applicable for x8 DRAMs only. When enabled via Mode Register A11 = 1 in MR1, the DRAM will enable the same termination resistance function on TDQS/ $\overline{\text{TDQS}}$ that is applied to DQS/ $\overline{\text{DQS}}$. When disabled via mode register A11 = 0 in MR1, DM/ $\overline{\text{TDQS}}$ will provide the data mask function and $\overline{\text{TDQS}}$ is not used. x4/x16 DRAMs must disable the TDQS function via mode register A11 = 0 in MR1. |
| NC | | No Connect: No internal electrical connection is present. |
| NU | | No Use |
| V _{DDQ} | Supply | DQ Power Supply: 1.5 V +/- 0.075 V |
| V _{SSQ} | Supply | DQ Ground |
| V _{DD} | Supply | Power Supply: 1.5 V +/- 0.075 V |
| V_{SS} | Supply | Ground |
| V _{REFDQ} | Supply | Reference voltage for DQ |
| V _{REFCA} | Supply | Reference voltage for CA |
| ZQ | Supply | Reference Pin for ZQ calibration |

Note:

Input only pins (BA0-BA2, A0-A15, RAS, CAS, WE, CS, CKE, ODT, DM, and RESET) do not supply termination.



ROW AND COLUMN ADDRESS TABLE

2Gb

| Configuration | 256Mb x 8 | 128Mb x 16 |
|------------------------|-----------|------------|
| # of Banks | 8 | 8 |
| Bank Address | BA0 - BA2 | BA0 - BA2 |
| Auto precharge | A10/AP | A10/AP |
| BL switch on the fly | A12/BC | A12/BC |
| Row Address | A0 - A14 | A0 - A13 |
| Column Address | A0 - A9 | A0 - A9 |
| Page size ¹ | 1 KB | 2 KB |

Note1: Page size is the number of bytes of data delivered from the array to the internal sense amplifiers when an ACTIVE command is registered. Page size is per bank, calculated as follows:

page size = 2 COLBITS * ORG ÷ 8

where COLBITS = the number of column address bits, ORG = the number of I/O (DQ) bits



Absolute Maximum Ratings

Absolute Maximum DC Ratings

Absolute Maximum DC Ratings

| Symbol | Parameter | Rating | Units | Notes |
|------------------------------------|-------------------------------------|------------------|-------|-------|
| VDD | Voltage on VDD pin relative to Vss | - 0.4 V ~ 1.80 V | V | 1,3 |
| VDDQ | Voltage on VDDQ pin relative to Vss | - 0.4 V ~ 1.80 V | V | 1,3 |
| V _{IN} , V _{OUT} | Voltage on any pin relative to Vss | - 0.4 V ~ 1.80 V | V | 1 |
| _ | Storage Temperature | -55 to +100 | °C | 1, 2 |

Notes:

- 1. Stresses greater than those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.
- 2. Storage Temperature is the case surface temperature on the center/top side of the DRAM. For the measurement conditions, please refer to JESD51-2 standard.
- 3. VDD and VDDQ must be within 300mV of each other at all times; and VREF must not be greater than 0.6XVDDQ,When VDD and VDDQ are less than 500mV; VREF may be equal to or less than 300mV.

DRAM Component Operating Temperature Range

Temperature Range

| Symbol | Parameter | Rating | Units | Notes |
|-------------------|------------------------------------|-----------|-------|-------|
| | Normal Operating Temperature Range | 0 to 85 | °C | 1,2 |
| T _{OPER} | Extended Temperature Range | 85 to 95 | οС | 1,4 |
| | Industrial Temperature Range | -40 to 95 | °C | 1,3,4 |

Notes:

- 1. Operating Temperature TOPER is the case surface temperature on the center / top side of the DRAM. For measurement conditions, please refer to the JEDEC document JESD51-2.
- 2. The Normal Temperature Range specifies the temperatures where all DRAM specifications will be supported. During operation, the DRAM case temperature must be maintained between 0 85oC under all operating conditions.
- 3. The Industrial Temperature Range specifies the temperatures where all DRAM specifications will be supported. During operation, the DRAM case temperature must be maintained between -40 85oC under all operating conditions.
- 4. Some applications require operation of the DRAM in the Extended Temperature Range between 85oC and 95oC case temperature. Full specifications are guaranteed in this range, but the following additional conditions apply:
- a. Refresh commands must be doubled in frequency, therefore reducing the Refresh interval tREFI to 3.9 µs.
- b. If Self-Refresh operation is required in the Extended Temperature Range, then it is mandatory to use the Manual Self-Refresh mode with Extended Temperature Range capability (MR2 A6 = 0b and MR2 A7 = 1b).



AC & DC Operating Conditions

Recommended DC Operating Conditions

Recommended DC Operating Conditions

| | | | Rating | | | |
|--------|---------------------------|-------|--------|-------|-------|-------|
| Symbol | Parameter | Min. | Тур. | Max. | Units | Notes |
| VDD | Supply Voltage | 1.425 | 1.500 | 1.575 | V | 1,2 |
| VDDQ | Supply Voltage for Output | 1.425 | 1.500 | 1.575 | V | 1,2 |

Notes:

- 1. Under all conditions, VDDQ must be less than or equal to VDD.
- 2. VDDQ tracks with VDD. AC parameters are measured with VDD and VDDQ tied together.



IDD and IDDQ Specification Parameters and Test Conditions IDD and IDDQ Measurement Conditions

In this chapter, IDD and IDDQ measurement conditions such as test load and patterns are defined. Figure 1. shows the setup and test load for IDD and IDDQ measurements.

- IDD currents (such as IDD0, IDD1, IDD2N, IDD2NT, IDD2P0, IDD2P1, IDD2Q, IDD3N, IDD3P, IDD4R, IDD4W, IDD5B, IDD6, IDD6TC and IDD7) are measured as time-averaged currents with all VDD balls of the DDR3 SDRAM under test tied together. Any IDDQ current is not included in IDD currents
- IDDQ currents (such as IDDQ2NT and IDDQ4R) are measured as time-averaged currents with all VDDQ balls of the DDR3 SDRAM under test tied together. Any IDD current is not included in IDDQ currents.

Attention: IDDQ values cannot be directly used to calculate IO power of the DDR3 SDRAM. They can be used to support correlation of simulated IO power to actual IO power as outlined in Figure 2. In DRAM module application, IDDQ cannot be measured separately since VDD and VDDQ are using one merged-power layer in Module PCB.

For IDD and IDDQ measurements, the following definitions apply:

- "0" and "LOW" is defined as VIN <= V_{ILAC(max)}.
- "1" and "HIGH" is defined as VIN >= V_{IHAC(max)}.
- "MID LEVEL" is defined as inputs are VREF = VDD/2.
- Timing used for IDD and IDDQ Measurement-Loop Patterns are provided in Table 1.
- Basic IDD and IDDQ Measurement Conditions are described in Table 2.
- Detailed IDD and IDDQ Measurement-Loop Patterns are described in Table 3 through Table 10.
- IDD Measurements are done after properly initializing the DDR3 SDRAM. This includes but is not limited to setting

```
RON = RZQ/7 (34 Ohm in MR1);

Qoff = 0_B (Output Buffer enabled in MR1);

RTT_Nom = RZQ/6 (40 Ohm in MR1);

RTT_Wr = RZQ/2 (120 Ohm in MR2);

TDQS Feature disabled in MR1
```

- Attention: The IDD and IDDQ Measurement-Loop Patterns need to be executed at least one time before actual IDD or IDDQ measurement is started.
- Define D = $\{\overline{CS}, \overline{RAS}, \overline{CAS}, \overline{WE}\}:= \{HIGH, LOW, LOW, LOW\}$
- Define $\overline{D} = {\overline{CS}, \overline{RAS}, \overline{CAS}, \overline{WE}} := {HIGH, HIGH, HIGH, HIGH}$



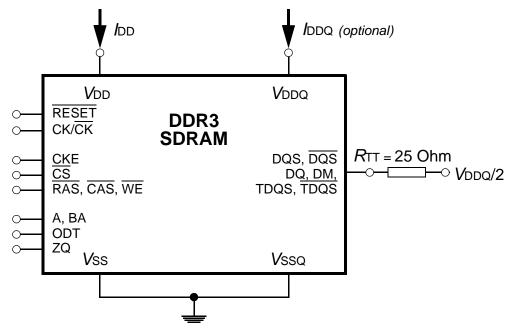


Figure 1 - Measurement Setup and Test Load for IDD and IDDQ (optional) Measurements [Note: DIMM level Output test load condition may be different from above]

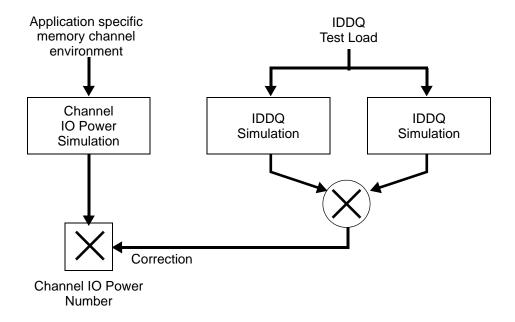


Figure 2 - Correlation from simulated Channel IO Power to actual Channel IO Power supported by IDDQ Measurement



Table 1 -Timings used for IDD and IDDQ Measurement-Loop Patterns

| c | vena ha l | DDR3-1066 | DDR3-1333 | DDR3-1600 | DDR3-1866 | DDR3-2133 | Uni |
|-------------------------|------------------|-----------|-----------|-----------|-----------|-----------|-----|
| 3 | ymbol | 7-7-7 | 9-9-9 | 11-11-11 | 13-13-13 | 14-14-14 | t |
| t_{CK} | | 1.875 | 1.5 | 1.25 | 1.07 | 0.935 | ns |
| CL | | 7 | 9 | 11 | 13 | 14 | nCK |
| $n_{\rm RCD}$ | | 7 | 9 | 11 | 13 | 14 | nCK |
| n_{RC} | | 27 | 33 | 39 | 45 | 50 | nCK |
| n_{RAS} | | 20 | 24 | 28 | 32 | 36 | nCK |
| $n_{\rm RP}$ | | 7 | 9 | 11 | 13 | 14 | nCK |
| | 1KB page size | 20 | 20 | 24 | 26 | 27 | nCK |
| n _{FAW} | 2KB page size | 27 | 30 | 32 | 33 | 38 | nCK |
| | 1KB page size | 4 | 4 | 5 | 5 | 6 | nCK |
| <i>n</i> _{RRD} | 2KB page size | 6 | 5 | 6 | 6 | 7 | nCK |
| n _{RFC} - | -512Mb | 48 | 60 | 72 | 85 | 97 | nCK |
| n _{RFC} -: | 1 Gb | 59 | 74 | 88 | 103 | 118 | nCK |
| n _{RFC} - | | 86 | 107 | 128 | 150 | 172 | nCK |
| n _{RFC} - | 4 Gb | 160 | 200 | 240 | 281 | 321 | nCK |
| n _{RFC} - | 8 Gb | 187 | 234 | 280 | 328 | 375 | nCK |

Table 2 -Basic IDD and IDDQ Measurement Conditions

| Symbol | Description |
|------------------|--|
| | Operating One Bank Active-Precharge Current |
| | CKE: High; External clock: On; tCK, nRC, nRAS, CL: see Table 1; BL: 8 ^{a)} ; AL: 0; CS: High between ACT |
| lone | and PRE; Command, Address, Bank Address Inputs: partially toggling according to Table 3; Data IO: |
| / _{DD0} | MID-LEVEL; DM: stable at 0; Bank Activity: Cycling with one bank active at a time: 0,0,1,1,2,2, (see |
| | Table 3); Output Buffer and RTT: Enabled in Mode Registers ^{b)} ; ODT Signal: stable at 0; Pattern Details: |
| | see Table 3. |



| Symbol | Description |
|--------------------|---|
| | Operating One Bank Active-Read-Precharge Current |
| / _{DD1} | CKE: High; External clock: On; tCK, nRC, nRAS, nRCD, CL: see Table 1; BL: 8 ^{a)} ; AL: 0; CS: High between ACT, RD and PRE; Command, Address; Bank Address Inputs, Data IO: partially toggling according to Table 4; DM: stable at 0; Bank Activity: Cycling with on bank active at a time: 0,0,1,1,2,2, (see Table 4); Output Buffer and RTT: Enabled in Mode Registers ^{b)} ; ODT Signal: stable at 0; Pattern Details: see |
| | Table 4. |
| | Precharge Standby Current |
| / _{DD2N} | CKE: High; External clock: On; tCK, CL: see Table 1; BL: 8 ^{a)} ; AL: 0; $\overline{\text{CS}}$: stable at 1; Command, Address, Bank Address Inputs: partially toggling according to Table 5; Data IO: MID_LEVEL; DM: stable at 0; |
| | Bank Activity: all banks closed; Output Buffer and RTT: Enabled in Mode Registers ^{b)} ; ODT Signal: stable at 0; Pattern Details: see Table 5. |
| | Precharge Standby ODT Current |
| / _{DD2NT} | CKE: High; External clock: On; tCK, CL: see Table 1; BL: 8 ^a); AL: 0; $\overline{\text{CS}}$: stable at 1; Command, Address, Bank Address Inputs: partially toggling according to Table 6; Data IO: MID_LEVEL; DM: stable at 0; |
| | Bank Activity: all banks closed; Output Buffer and RTT: Enabled in Mode Registers ^{b)} ; ODT Signal: tog- |
| | gling according to Table 6; Pattern Details: see Table 6. Precharge Power-Down Current Slow Exit |
| | CKE: Low; External clock: On; tCK, CL: see Table 1; BL: 8 ^{a)} ; AL: 0; $\overline{\text{CS}}$: stable at 1; Command, Address, |
| / _{DD2P0} | Bank Address Inputs: stable at 0; Data IO: MID_LEVEL; DM: stable at 0; Bank Activity: all banks closed; |
| | Output Buffer and RTT: Enabled in Mode Registers ^{b)} ; ODT Signal: stable at 0; Precharge Power Down Mode: Slow Exit ^{c)} |
| | Precharge Power-Down Current Fast Exit |
| J _{DD2P1} | CKE: Low; External clock: On; tCK, CL: see Table 1; BL: 8 ^a); AL: 0; CS: stable at 1; Command, Address, Bank Address Inputs: stable at 0; Data IO: MID_LEVEL; DM: stable at 0; Bank Activity: all banks closed; Output Buffer and RTT: Enabled in Mode Registers ^b); ODT Signal: stable at 0; Precharge Power Down |
| | Mode: Fast Exit ^{c)} Precharge Quiet Standby Current |
| | |
| I _{DD2Q} | CKE: High; External clock: On; tCK, CL: see Table 1; BL: 8 ^{a)} ; AL: 0; CS: stable at 1; Command, Address, Bank Address Inputs: stable at 0; Data IO: MID_LEVEL; DM: stable at 0; Bank Activity: all banks closed; |
| | Output Buffer and RTT: Enabled in Mode Registers ^{b)} ; ODT Signal: stable at 0 |



| Symbol | Description |
|-------------------|---|
| | Active Standby Current |
| / _{DD3N} | CKE: High; External clock: On; tCK, CL: see Table 1; BL: 8 ^{a)} ; AL: 0; CS: stable at 1; Command, Address, Bank Address Inputs: partially toggling according to Table 5; Data IO: MID_LEVEL; DM: stable at 0; |
| | Bank Activity: all banks open; Output Buffer and RTT: Enabled in Mode Registers ^{b)} ; ODT Signal: stable at 0; Pattern Details: see Table 5. |
| | Active Power-Down Current |
| / _{DD3P} | CKE: Low; External clock: On; tCK, CL: see Table 1; BL: 8 ^{a)} ; AL: 0; CS: stable at 1; Command, Address, |
| DD31 | Bank Address Inputs: stable at 0; Data IO: MID_LEVEL; DM: stable at 0; Bank Activity: all banks open; |
| | Output Buffer and RTT: Enabled in Mode Registers ^{b)} ; ODT Signal: stable at 0 |
| | Operating Burst Read Current |
| | CKE: High; External clock: On; tCK, CL: see Table 1; BL: 8 ^a); AL: 0; CS: High between RD; Command, |
| / _{DD4R} | Address, Bank Address Inputs: partially toggling according to Table 7; Data IO: seamless read data burst |
| 22 | with different data between one burst and the next one according to Table 7; DM: stable at 0; Bank |
| | Activity: all banks open, RD commands cycling through banks: 0,0,1,1,2,2,(see Table 7); Output Buffer |
| | and RTT: Enabled in Mode Registers ^{b)} ; ODT Signal: stable at 0; Pattern Details: see Table 7. |
| | Operating Burst Write Current |
| | CKE: High; External clock: On; tCK, CL: see Table 1; BL: 8 ^a); AL: 0; $\overline{\text{CS}}$: High between WR; Command, |
| I _{DD4W} | Address, Bank Address Inputs: partially toggling according to Table 8; Data IO: seamless read data burst |
| | with different data between one burst and the next one according to Table 8; DM: stable at 0; Bank Activity: all banks open, WR commands cycling through banks: 0,0,1,1,2,2,(see Table 8); Output Buf- |
| | fer and RTT: Enabled in Mode Registers ^{b)} ; ODT Signal: stable at HIGH; Pattern Details: see Table 8. |
| | Burst Refresh Current |
| | CKE: High; External clock: On; tCK, CL, nRFC: see Table 1; BL: 8 ^{a)} ; AL: 0; $\overline{\text{CS}}$: High between REF; Com- |
| / _{DD5B} | mand, Address, Bank Address Inputs: partially toggling according to Table 9; Data IO: MID_LEVEL; DM: |
| - DD3B | stable at 0; Bank Activity: REF command every nREF (see Table 9); Output Buffer and RTT: Enabled in |
| | Mode Registers ^{b)} ; ODT Signal: stable at 0; Pattern Details: see Table 9. |
| | Self-Refresh Current: Normal Temperature Range |
| | T _{CASE} : 0 - 85 °C; Auto Self-Refresh (ASR): Disabled ^{d)} ; Self-Refresh Temperature Range (SRT): Normal ^{e)} ; |
| I _{DD6} | CKE: Low; External clock: Off; CK and $\overline{\text{CK}}$: LOW; CL: see Table 1; BL: 8^{a} ; AL: 0; $\overline{\text{CS}}$, Command, Address, |
| | Bank Address Inputs, Data IO: MID_LEVEL; DM: stable at 0; Bank Activity: Self-Refresh operation; Out- |
| | put Buffer and RTT: Enabled in Mode Registers ^{b)} ; ODT Signal: MID_LEVEL |



| Symbol | Description |
|--------------------|--|
| | Self-Refresh Current: Extended Temperature Range (optional) ^{f)} |
| | T _{CASE} : 0 - 95 °C; Auto Self-Refresh (ASR): Disabled ^{d)} ; Self-Refresh Temperature Range (SRT): Extend- |
| / _{DD6ET} | ed ^{e)} ; CKE: Low; External clock: Off; CK and $\overline{\text{CK}}$: LOW; CL: see Table 1; BL: 8 ^{a)} ; AL: 0; $\overline{\text{CS}}$, Command, |
| 55021 | Address, Bank Address Inputs, Data IO: MID_LEVEL; DM: stable at 0; Bank Activity: Extended Tempera- |
| | ture Self-Refresh operation; Output Buffer and RTT: Enabled in Mode Registers ^{b)} ; ODT Signal: |
| | MID_LEVEL |
| | Operating Bank Interleave Read Current |
| | CKE: High; External clock: On; tCK, nRC, nRAS, nRCD, NRRD, nFAW, CL: see Table 1; BL: 8 ^{a), f)} ; AL: CL- |
| | 1; CS: High between ACT and RDA; Command, Address, Bank Address Inputs: partially toggling accord- |
| I _{DD7} | ing to Table 10; Data IO: read data burst with different data between one burst and the next one |
| | according to Table 10; DM: stable at 0; Bank Activity: two times interleaved cycling through banks (0, |
| | 1,7) with different addressing, wee Table 10; Output Buffer and RTT: Enabled in Mode Registers ^{b)} ; |
| | ODT Signal: stable at 0; Pattern Details: see Table 10. |

- a) Burst Length: BL8 fixed by MRS: set MR0 A[1,0]=00B
- b) Output Buffer Enable: set MR1 A[12] = 0B; set MR1 A[5,1] = 01B; RTT_Nom enable: set MR1 A[9,6,2] = 011B; RTT_Wr enable: set MR2 A[10,9] = 10B
- c) Precharge Power Down Mode: set MR0 A12=0B for Slow Exit or MR0 A12 = 1B for Fast Exit
- d) Auto Self-Refresh (ASR): set MR2 A6 = 0B to disable or 1B to enable feature
- e) Self-Refresh Temperature Range (SRT): set MR2 A7 = 0B for normal or 1B for extended temperature range
- f) Read Burst Type: Nibble Sequential, set MR0 A[3] = 0B



Table 3 - IDD0 Measurement-Loop Pattern^{a)}

| CK, CK | CKE | Sub-Loop | Cycle | Command | SS | RAS | CAS | WE | ООТ | BA[2:0] | A[15:11] | A[10] | A[9:7] | A[6:3] | A[2:0] | Data ^{b)} |
|----------|-------------|----------|------------|--|--|--------|--------|--------|----------|---------|----------|--------|--------|--------|--------|--------------------|
| | | 0 | 0 | ACT | 0 | 0 | 1 | 1 | 0 | 0 | 00 | 0 | 0 | 0 | 0 | - |
| | | | 1,2 | D, D | 1 | 0 | 0 | 0 | 0 | 0 | 00 | 0 | 0 | 0 | 0 | - |
| | | | 3,4 | \overline{D} , \overline{D} | 1 | 1 | 1 | 1 | 0 | 0 | 00 | 0 | 0 | 0 | 0 | - |
| | | | | repeat | patte | n 1 | 4 unti | l nRAS | 5 - 1, 1 | trunca | te if n | ecess | ary | | | |
| | | | nRAS | PRE | 0 | 0 | 1 | 0 | 0 | 0 | 00 | 0 | 0 | 0 | 0 | - |
| | | | | repeat | peat pattern 14 until nRC - 1, truncate if necessary | | | | | | | | | | | |
| | | | 1*nRC+0 | ACT | 0 | 0 | 1 | 1 | 0 | 0 | 00 | 0 | 0 | F | 0 | - |
| | | | 1*nRC+1, 2 | D, D | 1 | 0 | 0 | 0 | 0 | 0 | 00 | 0 | 0 | F | 0 | - |
| рп | Static High | | 1*nRC+3, 4 | D, D | 1 | 1 | 1 | 1 | 0 | 0 | 00 | 0 | 0 | F | 0 | - |
| toggling | 당 | | | repeat | patte | rn 1 | 4 unti | l 1*nF | RC + r | RAS - | 1, tru | ıncate | if nec | essary | , | |
| \$ | Stal | | 1*nRC+nRAS | PRE | 0 | 0 | 1 | 0 | 0 | 0 | 00 | 0 | 0 | F | 0 | - |
| | | | | repeat | patte | rn 1 | 4 unti | l 2*nF | RC - 1, | trunc | ate if | neces | sary | | | |
| | | 1 | 2*nRC | repeat | Sub-L | .oop 0 | , use | BA[2: | 0] = 1 | . inste | ad | | | | | |
| | | 2 | 4*nRC | repeat | Sub-L | .oop 0 | , use | BA[2: | 0] = 2 | inste | ad | | | | | |
| | | 3 | 6*nRC | repeat | Sub-L | .oop 0 | , use | BA[2: | 0] = 3 | inste | ad | | | | | |
| | | 4 | 8*nRC | repeat Sub-Loop 0, use BA[2:0] = 4 instead | | | | | | | | | | | | |
| | | 5 | 10*nRC | repeat | Sub-L | oop 0 | , use | BA[2: | 0] = 5 | inste | ad | | | | | |
| | | 6 | 12*nRC | repeat | Sub-L | oop 0 | , use | BA[2: | 0] = 6 | inste | ad | | | | | |
| | | 7 | 14*nRC | repeat Sub-Loop 0, use BA[2:0] = 6 instead repeat Sub-Loop 0, use BA[2:0] = 7 instead | | | | | | | | | | | | |

a) DM must be driven LOW all the time. DQS, $\overline{\text{DQS}}$ are MID-LEVEL.

b) DQ signals are MID-LEVEL.



Table 4 - IDD1 Measurement-Loop Patterna)

| CK, CK | CKE | Sub-Loop | Cycle | Command | SS | RAS | CAS | WE | ODT | BA[2:0] | A[15:11] | A[10] | A[9:7] | A[6:3] | A[2:0] | Data ^{b)} |
|----------|-------------|----------|------------|---------|-------|--------|--------|--------|----------|---------|----------|---------|--------|---------|--------|--------------------|
| | | 0 | 0 | ACT | 0 | 0 | 1 | 1 | 0 | 0 | 00 | 0 | 0 | 0 | 0 | - |
| | | | 1,2 | D, D | 1 | 0 | 0 | 0 | 0 | 0 | 00 | 0 | 0 | 0 | 0 | - |
| | | | 3,4 | D, D | 1 | 1 | 1 | 1 | 0 | 0 | 00 | 0 | 0 | 0 | 0 | - |
| | | | | repeat | patte | n 1 | 4 unti | InRCI |) - 1, 1 | trunca | te if n | ecess | ary | | | |
| | | | nRCD | RD | 0 | 1 | 0 | 1 | 0 | 0 | 00 | 0 | 0 | 0 | 0 | 00000000 |
| | | | | repeat | patte | rn 1 | 4 unti | I nRAS | S - 1, t | runca | te if ne | ecessa | ary | | | |
| | | | nRAS | PRE | 0 | 0 | 1 | 0 | 0 | 0 | 00 | 0 | 0 | 0 | 0 | - |
| | | | | repeat | patte | rn 1 | 4 unti | I nRC | - 1, tr | uncate | e if ned | cessar | γ | | | |
| | | | 1*nRC+0 | ACT | 0 | 0 | 1 | 1 | 0 | 0 | 00 | 0 | 0 | F | 0 | - |
| | | | 1*nRC+1,2 | D, D | 1 | 0 | 0 | 0 | 0 | 0 | 00 | 0 | 0 | F | 0 | - |
| рп | Static High | | 1*nRC+3,4 | D, D | 1 | 1 | 1 | 1 | 0 | 0 | 00 | 0 | 0 | F | 0 | - |
| toggling | Eic F | | | repeat | patte | n nRo | C + 1, | 4 ur | ntil nR | C + nl | RCE - | 1, trui | ncate | if nece | ssary | |
| \$ | Stal | | 1*nRC+nRCD | RD | 0 | 1 | 0 | 1 | 0 | 0 | 00 | 0 | 0 | F | 0 | 00110011 |
| | | | | repeat | patte | rn nR(| C + 1, | 4 ur | ntil nR | C + nl | RAS - | 1, trui | ncate | if nece | ssary | |
| | | | 1*nRC+nRAS | PRE | 0 | 0 | 1 | 0 | 0 | 0 | 00 | 0 | 0 | F | 0 | - |
| | | | | repeat | patte | rn nR(| C + 1, | 4 ur | ntil *2 | nRC - | 1, tru | ncate | if nec | essary | • | |
| | | 1 | 2*nRC | repeat | Sub-L | .oop 0 | , use | BA[2:0 | 0] = 1 | inste | ad | | | | | |
| | | 2 | 4*nRC | repeat | Sub-L | .oop 0 | , use | BA[2:0 | 0] = 2 | inste | ad | | | | | |
| | | 3 | 6*nRC | repeat | Sub-L | .oop 0 | , use | BA[2:0 | 0] = 3 | inste | ad | | | | | |
| | | 4 | 8*nRC | repeat | Sub-L | .oop 0 | , use | BA[2:0 | 0] = 4 | inste | ad | | | | | |
| | | 5 | 10*nRC | repeat | Sub-L | .oop 0 | , use | BA[2:0 | 0] = 5 | inste | ad | | | | | |
| | | 6 | 12*nRC | repeat | Sub-L | .oop 0 | , use | BA[2:0 | 0] = 6 | inste | ad | | | | | |
| | | 7 | 14*nRC | repeat | Sub-L | oop 0 | , use | BA[2:0 | 0] = 7 | inste | ad | | | | | |

a) DM must be driven LOW all the time. DQS, $\overline{\text{DQS}}$ are used according to RD Commands, otherwise MID-LEVEL.

b) Burst Sequence driven on each DQ signal by Read Command. Outside burst operation, DQ signals are MID_LEVEL.



Table 5 - IDD2N and IDD3N Measurement-Loop Patterna)

| CK, CK | CKE | Sub-Loop | Cycle Number | Command | SS | RAS | CAS | WE | TOO | BA[2:0] | A[15:11] | A[10] | A[9:7] | A[6:3] | A[2:0] | Data ^{b)} |
|----------|--------|----------|-----------------|--|-------|-------|-------|--------|--------|---------|----------|-------|--------|--------|--------|--------------------|
| | | 0 | 0 | D | 1 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | - |
| | | | 1 | D | 1 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | - |
| | | | 2 | D | 1 | 1 | 1 | 1 | 0 | 0 | 0 | 0 | 0 | F | 0 | - |
| | | | 3 | D | 1 | 1 | 1 | 1 | 0 | 0 | 0 | 0 | 0 | F | 0 | - |
| рu | High | 1 | 4-7 | repeat | Sub-L | oop 0 | , use | BA[2:0 |)] = 1 | instea | d | | | | | |
| toggling | | 2 | 8-11 | repeat | Sub-L | oop 0 | , use | BA[2:0 |)] = 2 | instea | d | | | | | |
| ğ | Static | 3 | 12-15 | repeat | Sub-L | oop 0 | , use | BA[2:0 |)] = 3 | instea | d | | | | | |
| | | 4 | 16-19 | repeat | Sub-L | oop 0 | , use | BA[2:0 |)] = 4 | instea | d | | | | | |
| | | 5 | 20-23 | repeat | Sub-L | oop 0 | , use | BA[2:0 |)] = 5 | instea | d | | | | | |
| | | 6 | 24-17 | repeat Sub-Loop 0, use BA[2:0] = 6 instead | | | | | | | | | | | | |
| | | 7 | 28-31 | repeat Sub-Loop 0, use BA[2:0] = 7 instead | | | | | | | | | | | | |

a) DM must be driven LOW all the time. DQS, $\overline{\text{DQS}}$ are MID-LEVEL.

Table 6 - IDD2NT and IDDQ2NT Measurement-Loop Patterna)

| CK, CK | CKE | Sub-Loop | Cycle Number | Command | SS | RAS | CAS | WE | ООТ | BA[2:0] | A[15:11] | A[10] | A[9:7] | A[6:3] | A[2:0] | Data ^{b)} |
|----------|--------|----------|-----------------|--|-------|--------|-------|-------|---------|---------|----------|-------|--------|--------|--------|--------------------|
| | | 0 | 0 | D | 1 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | - |
| | | | 1 | D | 1 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | - |
| | | | 2 | D | 1 | 1 | 1 | 1 | 0 | 0 | 0 | 0 | 0 | F | 0 | - |
| | | | 3 | D | 1 | 1 | 1 | 1 | 0 | 0 | 0 | 0 | 0 | F | 0 | - |
| р | High | 1 | 4-7 | repeat | Sub-L | .oop 0 | , but | ODT = | = 0 and | d BA[2 | 2:0] = | 1 | | | | |
| toggling | | 2 | 8-11 | repeat | Sub-L | .oop 0 | , but | ODT = | = 1 and | d BA[2 | 2:0] = | 2 | | | | |
| \$ | Static | 3 | 12-15 | repeat | Sub-L | oop 0 | , but | ODT = | = 1 and | d BA[2 | 2:0] = | 3 | | | | |
| | | 4 | 16-19 | repeat | Sub-L | .oop 0 | , but | ODT = | = 0 and | d BA[2 | 2:0] = | 4 | | | | |
| | | 5 | 20-23 | repeat | Sub-L | oop 0 | , but | ODT = | = 0 and | d BA[2 | 2:0] = | 5 | | | | |
| | | 6 | 24-17 | repeat Sub-Loop 0, but ODT = 1 and BA[2:0] = 6 | | | | | | | | | | | | |
| | | 7 | 28-31 | repeat Sub-Loop 0, but ODT = 1 and BA[2:0] = 7 | | | | | | | | | | | | |

a) DM must be driven LOW all the time. DQS, $\overline{\text{DQS}}$ are MID-LEVEL.

b) DQ signals are MID-LEVEL.

b) DQ signals are MID-LEVEL.



Table 7 - IDD4R and IDDQ4R Measurement-Loop Patterna)

| CK, CK | CKE | Sub-Loop | Cycle Number | Command | <u>SS</u> | RAS | CAS | WE | ODT | BA[2:0] | A[15:11] | A[10] | A[9:7] | A[6:3] | A[2:0] | Data ^{b)} |
|----------|--------|----------|-----------------|------------------------------------|-----------|-------|-------|--------|--------|---------|----------|-------|--------|--------|--------|--------------------|
| | | 0 | 0 | RD | 0 | 1 | 0 | 1 | 0 | 0 | 00 | 0 | 0 | 0 | 0 | 00000000 |
| | | | 1 | D | 1 | 0 | 0 | 0 | 0 | 0 | 00 | 0 | 0 | 0 | 0 | - |
| | | | 2,3 | D,D | 1 | 1 | 1 | 1 | 0 | 0 | 00 | 0 | 0 | 0 | 0 | - |
| | | | 4 | RD | 0 | 1 | 0 | 1 | 0 | 0 | 00 | 0 | 0 | F | 0 | 00110011 |
| | | | 5 | D | 1 | 0 | 0 | 0 | 0 | 0 | 00 | 0 | 0 | F | 0 | - |
| Бu | High | | 6,7 | D,D | 1 | 1 | 1 | 1 | 0 | 0 | 00 | 0 | 0 | F | 0 | - |
| toggling | tic F | 1 | 8-15 | repeat | Sub-L | oop 0 | , but | BA[2:0 |)] = 1 | | | | | | | |
| \$ | Static | 2 | 16-23 | repeat | Sub-L | oop 0 | , but | BA[2:0 |)] = 2 | | | | | | | |
| | | 3 | 24-31 | repeat | Sub-L | oop 0 | , but | BA[2:0 |)] = 3 | | | | | | | |
| | Ī | 4 | 32-39 | repeat | Sub-L | oop 0 | , but | BA[2:0 |)] = 4 | | | | | | | |
| | | 5 | 40-47 | repeat Sub-Loop 0, but BA[2:0] = 5 | | | | | | | | | | | | |
| | | 6 | 48-55 | repeat Sub-Loop 0, but BA[2:0] = 6 | | | | | | | | | | | | |
| | • | 7 | 56-63 | repeat Sub-Loop 0, but BA[2:0] = 7 | | | | | | | | | | | | |

a) DM must be driven LOW all the time. DQS, $\overline{\text{DQS}}$ are used according to RD Commands, otherwise MID-LEVEL.

b) Burst Sequence driven on each DQ signal by Read Command. Outside burst operation, DQ signals are MID-LEVEL.



Table 8 - IDD4W Measurement-Loop Patterna)

| CK, CK | CKE | Sub-Loop | Cycle Number | Command | SS | RAS | CAS | WE | ODT | BA[2:0] | A[15:11] | A[10] | A[9:7] | A[6:3] | A[2:0] | Data ^{b)} |
|----------|--------|----------|-----------------|------------------------------------|-------|--------|-------|--------|--------|---------|----------|-------|--------|--------|--------|--------------------|
| | | 0 | 0 | WR | 0 | 1 | 0 | 0 | 1 | 0 | 00 | 0 | 0 | 0 | 0 | 00000000 |
| | | | 1 | D | 1 | 0 | 0 | 0 | 1 | 0 | 00 | 0 | 0 | 0 | 0 | - |
| | | | 2,3 | D,D | 1 | 1 | 1 | 1 | 1 | 0 | 00 | 0 | 0 | 0 | 0 | - |
| | | | 4 | WR | 0 | 1 | 0 | 0 | 1 | 0 | 00 | 0 | 0 | F | 0 | 00110011 |
| | | | 5 | D | 1 | 0 | 0 | 0 | 1 | 0 | 00 | 0 | 0 | F | 0 | - |
| рu | High | | 6,7 | D,D | 1 | 1 | 1 | 1 | 1 | 0 | 00 | 0 | 0 | F | 0 | - |
| toggling | ic F | 1 | 8-15 | repeat | Sub-L | oop 0 | , but | BA[2:0 |)] = 1 | | | | | | | |
| \$ | Static | 2 | 16-23 | repeat | Sub-L | .oop 0 | , but | BA[2:0 |)] = 2 | | | | | | | |
| | | 3 | 24-31 | repeat | Sub-L | .oop 0 | , but | BA[2:0 |)] = 3 | | | | | | | |
| | | 4 | 32-39 | repeat | Sub-L | .oop 0 | , but | BA[2:0 |)] = 4 | | | | | | | |
| | | 5 | 40-47 | repeat | Sub-L | .oop 0 | , but | BA[2:0 |)] = 5 | | | | | | | |
| | | 6 | 48-55 | repeat | Sub-L | .oop 0 | , but | BA[2:0 |)] = 6 | | | | | | | |
| | | 7 | 56-63 | repeat Sub-Loop 0, but BA[2:0] = 7 | | | | | | | | | | | | |

a) DM must be driven LOW all the time. DQS, \overline{DQS} are used according to WR Commands, otherwise MID-LEVEL.

Table 9 - IDD5B Measurement-Loop Patterna)

| CK, CK | CKE | Sub-Loop | Cycle | Command | <u>SS</u> | RAS | CAS | WE | ODT | BA[2:0] | A[15:11] | A[10] | A[9:7] | A[6:3] | A[2:0] | Data ^{b)} |
|----------|--------|----------|----------|-------------------------------------|--------------------------------|--------|---------|--------|--------|---------|----------|--------|--------|--------|--------|--------------------|
| | | 0 | 0 | REF | 0 | 0 | 0 | 1 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | - |
| | | 1 | 1.2 | D, D | 1 | 0 | 0 | 0 | 0 | 0 | 00 | 0 | 0 | 0 | 0 | - |
| | | | 3,4 | D, D | 1 | 1 | 1 | 1 | 0 | 0 | 00 | 0 | 0 | F | 0 | - |
| | | | 58 | repeat cycles 14, but $BA[2:0] = 1$ | | | | | | | | | | | | |
| Бu | High | | 912 | repeat cycles 14, but BA[2:0] = 2 | | | | | | | | | | | | |
| toggling | | | 1316 | repeat | eat cycles 14, but BA[2:0] = 3 | | | | | | | | | | | |
| \$ | Static | | 1720 | repeat | cycles | 5 14 | , but I | BA[2:0 |] = 4 | | | | | | | |
| | | | 2124 | repeat | cycles | 3 14 | , but I | BA[2:0 |] = 5 | | | | | | | |
| | | | 2528 | repeat | cycles | 5 14 | , but I | BA[2:0 |] = 6 | | | | | | | |
| | | | 2932 | repeat cycles 14, but BA[2:0] = 7 | | | | | | | | | | | | |
| | | 2 | 33nRFC-1 | repeat | Sub-L | .oop 1 | , until | nRFC | - 1. T | runca | te, if n | ecessa | ary. | | | |

a) DM must be driven LOW all the time. DQS, \overline{DQS} are MID-LEVEL.

b) Burst Sequence driven on each DQ signal by Write Command. Outside burst operation, DQ signals are MID-LEVEL.

b) DQ signals are MID-LEVEL.



Table 10 - IDD7 Measurement-Loop Patterna)

ATTENTION! Sub-Loops 10-19 have inverse A[6:3] Pattern and Data Pattern than Sub-Loops 0-9

| CK, CK | CKE | Sub-Loop | Cycle Number | Command | <u>SS</u> | RAS | CAS | WE | ODT | BA[2:0] | A[15:11] | A[10] | A[9:7] | A[6:3] | A[2:0] | Data ^{b)} |
|----------|-------------|----------|--------------------|--|--|------------|-----------|-------------|-----------|------------|--------------|-----------|-------------|--------------|-------------|--------------------|
| | | 0 | 0 | ACT | 0 | 0 | 1 | 1 | 0 | 0 | 00 | 0 | 0 | 0 | 0 | - |
| | | | 1 | RDA | 0 | 1 | 0 | 1 | 0 | 0 | 00 | 1 | 0 | 0 | 0 | 00000000 |
| | | | 2 | D | 1 | 0 | 0 | 0 | 0 | 0 | 00 | 0 | 0 | 0 | 0 | - |
| | | | | repeat | above | D C | omma | nd ur | til nR | RD - : | | - | | | - | - |
| | | | nRRD | ACT | 0 | 0 | 1 | 1 | 0 | 1 | 00 | 0 | 0 | F | 0 | - |
| | | | nRRD+1 | RDA | 0 | 1 | 0 | 1 | 0 | 1 | 00 | 1 | 0 | F | 0 | 00110011 |
| | | 1 | nRRD+2 | D | 1 | 0 | 0 | 0 | 0 | 1 | 00 | 0 | 0 | F | 0 | - |
| | | | | repeat | above | D C | omma | and ur | til 2* | nRRD | - 1 | 1 | 1 | | | 1 |
| | | 2 | 2*nRRD | repeat | Sub-L | oop (| 0, but | BA[2: | = [0: | 2 | | | | | | |
| | | 3 | 3*nRRD | repeat | Sub-L | oop | 1, but | BA[2: | = [0: | 3 | | | | | | |
| | | 1 | 4*nRRD | D | 1 | 0 | 0 | 0 | 0 | 3 | 00 | 0 | 0 | F | 0 | - |
| | | 4 | | Assert | and r | epeat | abov | e D C | omma | nd ur | itil nF | ٩W - | 1, if n | ecessa | ary | |
| | | 5 | nFAW | repeat | Assert and repeat above D Command until nFAW - 1, if necessary epeat Sub-Loop 0, but BA[2:0] = 4 | | | | | | | | | | | |
| | | 6 | nFAW+nRRD | repeat | epeat Sub-Loop 1, but BA[2:0] = 5 | | | | | | | | | | | |
| | | 7 | nFAW+2*nRRD | repeat | peat Sub-Loop 0, but BA[2:0] = 6 | | | | | | | | | | | |
| | | 8 | nFAW+3*nRRD | repeat | peat Sub-Loop 1, but BA[2:0] = 7 | | | | | | | | | | | |
| _ | 년 | 9 | nFAW+4*nRRD | D | 1 | 0 | 0 | 0 | 0 | 7 | 00 | 0 | 0 | F | 0 | - |
| toggling | Static High | 9 | | Assert | and r | epeat | abov | e D C | omma | nd ur | til 2* | nFAV | V - 1, | if nece | essary | , |
| bbc | atic | | 2*nFAW+0 | ACT | 0 | 0 | 1 | 1 | 0 | 0 | 00 | 0 | 0 | F | 0 | - |
| 4 | St | 10 | 2*nFAW+1 | RDA | 0 | 1 | 0 | 1 | 0 | 0 | 00 | 1 | 0 | F | 0 | 00110011 |
| | | | 2&nFAW+2 | D | 1 | 0 | 0 | 0 | 0 | 0 | 00 | 0 | 0 | F | 0 | - |
| | | | ZXIIFAVV+Z | Repeat above D Command until 2* nFAW + nRRD - 1 | | | | | | | | | | | | |
| | | | 2*nFAW+nRRD | ACT | 0 | 0 | 1 | 1 | 0 | 1 | 00 | 0 | 0 | 0 | 0 | - |
| | | 11 | 2*nFAW+nRRD+1 | RDA | 0 | 1 | 0 | 1 | 0 | 1 | 00 | 1 | 0 | 0 | 0 | 00000000 |
| | | 11 | 2&nFAW+nRRD+ | D | 1 | 0 | 0 | 0 | 0 | 1 | 00 | 0 | 0 | 0 | 0 | - |
| | | | 2 | Repeat above D Command until 2* nFAW + 2* nRRD - 1 | | | | | | | | | | | | |
| | | 12 | 2*nFAW+2*nRRD | repeat | Sub-L | oop : | 10, bu | it BA[2 | 2:0] = | 2 | | | | | | |
| | | 13 | 2*nFAW+3*nRRD | repeat | Sub-L | oop : | 11, bu | it BA[2 | 2:0] = | 3 | | | | | | |
| | | 14 | 2*nFAW+4*nRRD | D | 1 | 0 | 0 | 0 | 0 | 3 | 00 | 0 | 0 | 0 | 0 | - |
| | | 17 | Z TIII AVVTT TIKKD | Assert | and r | epeat | abov | e D C | omma | nd ur | til 3* | nFAV | V - 1, | if nece | essary | |
| | | 15 | 3*nFAW | repeat | Sub-l | oop : | 10, bu | it BA[2 | 2:0] = | : 4 | | | | | | |
| | | 16 | 3*nFAW+nRRD | repeat | Sub-L | oop : | 11, bu | ıt BA[| 2:0] = | 5 | | | | | | |
| | | 17 | 3*nFAW+2*nRRD | repeat | Sub-L | oop : | 10, bu | it BA[2 | 2:0] = | 6 | | | | | | |
| | | 18 | 3*nFAW+3*nRRD | repeat | Sub-L | oop : | 11, bu | it BA[2 | 2:0] = | : 7 | | | | | | |
| | | 19 | 3*nFAW+4*nRRD | D Assert | 1 and r | 0 epeat | 0 abov | 0 e D Co | 0 omma | 7 nd ur | 00 til 4* | 0 nFAV | 0 V - 1. | 0 if nece | 0 essarv | - |
| L | | | | . 10001 | J J. 1 | -p-ut | | | u | | | / ١٧ | , | | JJJJUI Y | |

a) DM must be driven LOW all the time. DQS, $\overline{\text{DQS}}$ are used according to RD Commands, otherwise MID-LEVEL.

b) Burst Sequence driven on each DQ signal by Read Command. Outside burst operation, DQ signals are MID-LEVEL.



IDD Specifications

IDD values are for full operating range of voltage and temperature unless otherwise noted.

IDD Specification

| Speed Grade Bin | DDR3 - 1066 7-7-7 | DDR3 - 1333 9-9-9 | DDR3 - 1600 11-11-11 | DDR3 - 1866 13-13-13 | DDR3 - 2133 14-14-14 | Unit | Notes |
|----------------------|----------------------|----------------------|-------------------------|--|-------------------------|---|-------|
| Symbol | Max. | Max. | Max. | Max. | Max. | | |
| | 27 | 27 | 32 | Max. Max. 32 32 mA x8 39 40 mA x1 36 41 mA x6 50 54 mA x1 11 11 mA x8/ 11 11 mA x1 16 18 mA x8/ 21 23 mA x1 16 18 mA x1 16 18 mA x1 22 23 mA x1 22 23 mA x1 28 29 mA x1 28 29 mA x1 28 29 mA x1 92 98 mA x1 92 98 mA x1 92 102 mA x1 147 150 mA x1 147 150 mA x1 | x8 | | |
| I_{DD0} | 36 | 36 | 38 | 39 | 40 | mA x mA x1 mA x8/ mA x8/ mA x8/ mA x1 mA x8/ mA x8/ mA x8/ mA x8/ mA x8/ mA x8/ | x16 |
| 7 | 32 | 36 | 36 | 36 | 41 | mA | x8 |
| I_{DD01} | 45 | 45 | 50 | 50 | 54 | mA | x16 |
| I_{DD2P0} | 11 | 11 | 11 | 11 | 11 | mA | x8/16 |
| 7 | 11 | 11 | 11 | 11 | 11 | mA | x8 |
| I_{DD2P1} | 11 | 11 | 11 | 11 | 11 | mA | x16 |
| I_{DD2N} | 14 | 14 | 14 | 16 | 18 | mA | x8/16 |
| 7 | 16 | 18 | 19 | 21 | 23 | mA | x8 |
| I_{DD2NT} | 18 | 18 | 19 | 21 | 23 | mA | x16 |
| 7 | 14 | 14 | 16 | 16 | 18 | mA | x8 |
| I_{DD2Q} | 16 | 16 | 16 | 16 | 18 | mA x mA mA mA mA mA mA mA mA | x16 |
| 7 | 21 | 21 | 21 | 22 | 23 | mA | x8 |
| I_{DD3P} | 25 | 26 | 26 | 26 | 27 | mA | x16 |
| <i>T</i> | 25 | 26 | 27 | 28 | 29 | mA | x8 |
| I_{DD3N} | 32 | 33 | 34 | 35 | 36 | mA | x16 |
| | 57 | 69 | 82 | 92 | 98 | mA | x8 |
| I_{DD4R} | 105 | 108 | 125 | 135 | 150 | mA | x16 |
| <i>I</i> | 63 | 75 | 82 | 92 | 102 | mA | x8 |
| I_{DD4w} | 105 | 108 | 125 | 135 | 150 | mA | x16 |
| T | 145 | 145 | 147 | 147 | 150 | mA | x8 |
| I_{DD5B} | 150 | 150 | 155 | 156 | 158 | mA | x16 |
| Normal | 10 | 10 | 10 | 10 | 10 | mA | x8/16 |
| I _{DD6} Low | 6 | 6 | 6 | 6 | 6 | mA | x8 |
| power | 6 | 6 | 6 | 6 | 6 | mA | x16 |
| I_{DD6ET} | 12 | 12 | 12 | 12 | 12 | mA | x8/16 |
| | 105 | 115 | 120 | 135 | 150 | mA | x8 |
| I_{DD7} | 180 | 180 | 194 | 198 | 216 | mA | x16 |

Notes:

- 1. Applicable for MR2 settings A6=0 and A7=0. Temperature range for IDD6 is 0 85°C.
- 2. Applicable for MR2 settings A6=0 and A7=1. Temperature range for IDD6ET is 0 95° C.



Input/Output Capacitance

| Parameter | Symbol | DDR3 | -1066 | DDR3 | -1333 | DDR3 | -1600 | DDR3 | -1866 | DDR3 | -2133 | Units | Notes |
|---|----------------------|------|-------|------|-------|------|-------|------|-------|------|-------|--------|----------|
| Parameter | Symbol | Min | Max | UIIIIS | Notes |
| Input/output capacitance (DQ, DM, DQS, DQS, TDQS, TDQS) | C _{IO} | 1.5 | 2.7 | 1.5 | 2.5 | 1.5 | 2.3 | 1.4 | 2.2 | 1.4 | 2.1 | pF | 1,2,3 |
| Input capacitance, CK and CK | C _{CK} | 0.8 | 1.6 | 0.8 | 1.4 | 0.8 | 1.4 | 0.8 | 1.3 | 0.8 | 1.3 | pF | 2,3 |
| Input capacitance delta CK and CK | C _{DCK} | 0 | 0.15 | 0 | 0.15 | 0 | 0.15 | 0 | 0.15 | 0 | 0.15 | pF | 2,3,4 |
| Input capacitance delta, DQS and DQS | C _{DDQS} | 0 | 0.20 | 0 | 0.15 | 0 | 0.15 | 0 | 0.15 | 0 | 0.15 | pF | 2,3,5 |
| Input capacitance (All other input-only pins) | C _I | 0.75 | 1.35 | 0.75 | 1.3 | 0.75 | 1.3 | 0.75 | 1.2 | 0.75 | 1.2 | pF | 2,3,6 |
| Input capacitance delta (All CTRL input-only pins) | C _{DI_CTRL} | -0.5 | 0.3 | -0.4 | 0.2 | -0.4 | 0.2 | -0.4 | 0.2 | -0.4 | 0.2 | pF | 2,3,7,8 |
| Input capacitance delta (All ADD/CMD input-only pins) | C _{DI_ADD_} | -0.5 | 0.5 | -0.4 | 0.4 | -0.4 | 0.4 | -0.4 | 0.4 | -0.4 | 0.4 | pF | 2,3,9,10 |
| Input/output capacitance delta (DQ, DM, DQS, DQS) | C _{DIO} | -0.5 | 0.3 | -0.5 | 0.3 | -0.5 | 0.3 | -0.5 | 0.3 | -0.5 | 0.3 | pF | 2,3,11 |
| Input/output capacitance of ZQ pin | C _{ZQ} | - | 3 | - | 3 | - | 3 | - | 3 | - | 3 | pF | 2,3,12 |

Notes:

- 1. Although the DM, TDQS and $\overline{\text{TDQS}}$ pins have different functions, the loading matches DQ and DQS.
- 2. This parameter is not subject to production test. It is verified by design and characterization. The capacitance is measured according to JEP147("PROCEDURE FOR MEASURING INPUT CAPACITANCE USING A VECTOR NETWORK ANALYZER(VNA)") with VDD, VDDQ, VSS,VSSQ applied and all other pins floating (except the pin under test, CKE, RESET and ODT as necessary). VDD=VDDQ=1.5V, VBIAS=VDD/2 and on-die termination off.
- 3. This parameter applies to monolithic devices only; stacked/dual-die devices are not covered here
- 4. Absolute value of C_{CK} - $C_{\overline{CK}}$.
- 5. Absolute value of $C_{IO}(DQS)-C_{IO}(\overline{DQS})$.
- 6. C_I applies to ODT, \overline{CS} , CKE, A0-A15, BA0-BA2, \overline{RAS} , \overline{CAS} , \overline{WE} .
- 7. $C_{DI\ CTR}$ applies to ODT, \overline{CS} and CKE.
- 8. $C_{DI CTRL} = C_I(CNTL) 0.5 * C_I(CLK) + C_I(\overline{CLK})$
- 9. $C_{DI\ ADD\ CMD}$ applies to A0-A15, BA0-BA2, \overline{RAS} , \overline{CAS} and \overline{WE} .
- 10. $C_{DI ADD CMD} = C_I(ADD_CMD) 0.5*(C_I(CLK) + C_I(\overline{CLK}))$
- 11. $C_{DIO} = C_{IO}(DQ) 0.5*(C_{IO}(DQS) + C_{IO}(\overline{DQS}))$
- 12. Maximum external load capacitance an ZQ pin: 5 pF.



Standard Speed Bins

DDR3 SDRAM Standard Speed Bins include tCK, tRCD, tRP, tRAS and tRC for each corresponding bin.

DDR3-1066 Speed Bins

For specific Notes See "Speed Bin table Notes" on page 31.

| | Speed Bin | | DDR3- | 1066F | | |
|-----------------------|-------------------------------|-------------------------|-----------------|-----------|-----------------|------------------------------|
| C | L - nRCD - nR | P | 7-7 | Unit | Note | |
| Par | Parameter | | min | max | | |
| | ad command to st data | t _{AA} | 13.125 | 20 | ns | |
| | iternal read or delay time | <i>t</i> _{RCD} | 13.125 | _ | ns | |
| PRE con | nmand period | <i>t</i> _{RP} | 13.125 | _ | ns | |
| | ACT or REF and period | <i>t</i> _{RC} | 50.625 | _ | ns | |
| | RE command period | t _{RAS} | 37.5 | 9 * tREFI | ns | |
| CL = 5 | CWL = 5 | t _{CK(AVG)} | 3.0 | 3.3 | ns | 1, 2, 3, 4, 6, 12,13 4 |
| | CWL = 6 | t _{CK(AVG)} | Rese | ns | 4 | |
| CL = 6 | CWL = 5 | t _{CK(AVG)} | 2.5 | 3.3 | ns | 1, 2, 3, 6 |
| CL = 0 | CWL = 6 | t _{CK(AVG)} | Rese | rved | ns | 1, 2, 3, 4 |
| Cl 7 | CWL = 5 | t _{CK(AVG)} | Rese | rved | ns | 4 |
| CL = 7 | CWL = 6 | t _{CK(AVG)} | 1.875 | < 2.5 | ns | 1, 2, 3, 4 |
| CL = 8 | CWL = 5 | t _{CK(AVG)} | Rese | rved | ns | 4 |
| CL = 8 | | t _{CK(AVG)} | 1.875 | < 2.5 | ns | 1, 2, 3 |
| Supported CL Settings | | 5, 6, | n _{CK} | 13 | | |
| Sup | ported CWL Sett | tings | 5, | 6 | n _{CK} | |



DDR3-1333 Speed Bins

For specific Notes See "Speed Bin table Notes" on page 31.

| | Speed Bin | | D | DR3-1333H | | |
|---------|-------------------------------------|-------------------------|--------------------------------|--------------------------|-----------------|-------------------------|
| | L - nRCD - nl | DD | | 9-9-9 | Unit | Note |
| | ameter | Symbol | min | max | | |
| Inte | Internal read command to first data | | 13.5 (13.125) ¹¹ | 20 | ns | |
| | ternal read or delay time | <i>t</i> _{RCD} | 13.5 (13.125) ¹¹ | _ | ns | |
| PRE com | nmand period | t _{RP} | 13.5 (13.125) ¹¹ | _ | ns | |
| | ACT or REF and period | t _{RC} | 49.5 (49.125) ¹¹ | _ | ns | |
| | ACT to PRE command period | | 36 | 9 * tREFI | ns | |
| CL = 5 | CWL = 5 | t _{CK(AVG)} | 3.0 | 3.3 | ns | 1, 2, 3, 4, 7, 12,13 |
| | CWL = 6, 7 | t _{CK(AVG)} | | Reserved | ns | 4 |
| | CWL = 5 | t _{CK(AVG)} | 2.5 | 3.3 | ns | 1, 2, 3, 7 |
| CL = 6 | CWL = 6 | t _{CK(AVG)} | | Reserved | ns | 1, 2, 3, 4, 7 |
| | CWL = 7 | t _{CK(AVG)} | Reserved | | ns | 4 |
| | CWL = 5 | t _{CK(AVG)} | | Reserved | ns | 4 |
| CI 7 | CMI | _ | 1.875 | < 2.5 | | 1 2 2 4 7 |
| CL = 7 | CWL = 6 | t _{CK(AVG)} | | (Optional) ¹¹ | ns | 1, 2, 3, 4, 7 |
| | CWL = 7 | t _{CK(AVG)} | | Reserved | ns | 1, 2, 3, 4 |
| | CWL = 5 | t _{CK(AVG)} | | Reserved | ns | 4 |
| CL = 8 | CWL = 6 | t _{CK(AVG)} | 1.875 | < 2.5 | ns | 1, 2, 3, 7 |
| | CWL = 7 | t _{CK(AVG)} | | Reserved | ns | 1, 2, 3, 4 |
| CI O | CWL = 5, 6 | t _{CK(AVG)} | | Reserved | ns | 4 |
| CL = 9 | CWL = 7 | t _{CK(AVG)} | 1.5 | <1.875 | ns | 1, 2, 3, 4 |
| | CWL = 5, 6 | t _{CK(AVG)} | | Reserved | ns | 4 |
| CL = 10 | CWL = 7 | t _{CK(AVG)} | 1.5 | <1.875 | ns | 1, 2, 3 |
| | | | | (Optional) | ns | 5 |
| | ported CL Set | | 5, 6 | , 8, (7), 9, (10) | n _{CK} | |
| Supp | orted CWL Se | ettings | | 5, 6, 7 | n _{CK} | |



DDR3-1600 Speed Bins

For specific Notes See "Speed Bin table Notes" on page 31.

| Speed Bin | | | С | DDR3-1600K | | |
|-----------|-----------------------------|-----------------------------|---------------------------------|-------------------------------|-----------------|--------------------------|
| CI | nRCD - nl | RP | | 11-11-11 | Unit | Note |
| Par | ameter | Symbol | min | max | | |
| | nal read I to first data | t _{AA} | 13.75 (13.125) ¹¹ | 20 | ns | |
| | ernal read or delay time | <i>t</i> _{RCD} | 13.75 (13.125) ¹¹ | _ | ns | |
| PRE com | mand period | t _{RP} | 13.75 (13.125) ¹¹ | _ | ns | |
| | ACT or REF and period | <i>t</i> _{RC} | 48.75 (48.125) ¹¹ | _ | ns | |
| | RE command eriod | t _{RAS} | 35 | 9 * tREFI | ns | |
| CL = 5 | CWL = 5 | t _{CK(AVG)} | 3.0 | 3.3 | ns | 1, 2, 3, 4, 8, 12, 13 |
| | CWL = 6, 7 | t _{CK(AVG)} | | Reserved | ns | 4 |
| | CWL = 5 | t _{CK(AVG)} | 2.5 | 3.3 | ns | 1, 2, 3, 8 |
| CL = 6 | CWL = 6 | t _{CK(AVG)} | | Reserved | ns | 1, 2, 3, 4, 8 |
| | CWL = 7 | t _{CK(AVG)} | | Reserved | ns | 4 |
| | CWL = 5 | t _{CK(AVG)} | | Reserved | ns | 4 |
| CL = 7 | CWL = 6 | t _{CK(AVG)} | 1.875 | < 2.5 (Optional) ⁵ | ns | 1, 2, 3, 4, 8 |
| - | CWL = 7 | t _{CK(AVG)} | | Reserved | ns | 1, 2, 3, 4, 8 |
| | CWL = 8 | t _{CK(AVG)} | Reserved | | ns | 4 |
| | CWL = 5 | t _{CK(AVG)} | | Reserved | ns | 4 |
| - | CWL = 6 | t _{CK(AVG)} | 1.875 | < 2.5 | ns | 1, 2, 3, 8 |
| CL = 8 | CWL = 7 | t _{CK(AVG)} | | Reserved | ns | 1, 2, 3, 4, 8 |
| | CWL = 8 | t _{CK(AVG)} | | Reserved | ns | 1, 2, 3, 4 |
| | CWL = 5, 6 | t _{CK(AVG)} | | Reserved | ns | 4 |
| | - | | 1.5 | <1.875 | | 1 |
| CL = 9 | CWL = 7 | t _{CK(AVG)} | | (Optional) ⁵ | ns | 1, 2, 3, 4, 8 |
| | CWL = 8 | <i>t</i> _{CK(AVG)} | | Reserved | ns | 1, 2, 3, 4 |
| | CWL = 5, 6 | t _{CK(AVG)} | | Reserved | ns | 4 |
| CL = 10 | CWL = 7 | t _{CK(AVG)} | 1.5 | <1.875 | ns | 1, 2, 3, 8 |
| | CWL = 8 | t _{CK(AVG)} | | Reserved | ns | 1, 2, 3, 4 |
| | CWL = 5, 6,7 | t _{CK(AVG)} | | Reserved | ns | 4 |
| CL = 11 | CWL = 8 | t _{CK(AVG)} | 1.25 | <1.5 | ns | 1, 2, 3 |
| Sup | ported CL Set | | | (7), 8, (9), 10, 11 | $n_{\rm CK}$ | , , |
| | orted CWL Se | _ | · • | 5, 6, 7, 8 | n _{CK} | |



DDR3-1866 Speed Bins

For specific Notes See "Speed Bin Table Notes" on page 31.

| | Speed Bin | | Г | DDR3-1866M | | |
|----------------------------------|-------------------------------|-------------------------|---------------------------------|-----------------|-----------------|---------------|
| (| CL - nRCD - nR | P. | | 13-13-13 | Unit | Note |
| Pa | rameter | Symbol | min | max | | |
| | read command first data | t _{AA} | 13.91 (13.125) ¹³ | 20 | ns | |
| | nternal read or delay time | <i>t</i> _{RCD} | 13.91 (13.125) ¹³ | _ | ns | |
| PRE cor | mmand period | <i>t</i> _{RP} | 13.91 (13.125) ¹³ | _ | ns | |
| | PRE command period | t _{RAS} | 34 | 9 * tREFI | ns | |
| ACT to ACT or PRE command period | | t _{RC} | 47.91 (47.125) ¹³ | - | ns | |
| CL = 5 | CWL = 5 | t _{CK(AVG)} | 3.0 | 3.3 | ns | 1, 2, 3, 4, 9 |
| | CWL = 6,7,8,9 | t _{CK(AVG)} | | Reserved | ns | 4 |
| | CWL = 5 | t _{CK(AVG)} | 2.5 | 3.3 | ns | 1, 2, 3, 9 |
| CL = 6 | CWL = 6 | t _{CK(AVG)} | | Reserved | ns | 1, 2, 3, 4, 9 |
| | CWL = 7,8,9 | t _{CK(AVG)} | | Reserved | ns | 4 |
| CL = 7 | CWL = 5 | t _{CK(AVG)} | | Reserved | ns | 4 |
| | CWL = 6 | t _{CK(AVG)} | 1.875 | < 2.5 | ns | 1, 2, 3, 4, 9 |
| | CWL = 7,8,9 | t _{CK(AVG)} | | Reserved | ns | 4 |
| | CWL = 5 | t _{CK(AVG)} | | Reserved | ns | 4 |
| CL = 8 | CWL = 6 | t _{CK(AVG)} | 1.875 | < 2.5 | ns | 1, 2, 3, 9 |
| CL = 0 | CWL = 7 | t _{CK(AVG)} | | Reserved | ns | 1, 2, 3, 4, 9 |
| | CWL = 8,9 | t _{CK(AVG)} | | Reserved | ns | 4 |
| | CWL = 5, 6 | t _{CK(AVG)} | | Reserved | ns | 4 |
| CL = 9 | CWL = 7 | t _{CK(AVG)} | 1.5 | <1.875 | ns | 1, 2, 3, 4, 9 |
| CL = 9 | CWL = 8 | t _{CK(AVG)} | | Reserved | ns | 1, 2, 3, 4, 9 |
| | CWL = 9 | t _{CK(AVG)} | | Reserved | ns | 4 |
| | CWL = 5, 6 | t _{CK(AVG)} | | Reserved | ns | 4 |
| CL = 10 | CWL = 7 | t _{CK(AVG)} | 1.5 | <1.875 | ns | 1, 2, 3, 9 |
| | CWL = 8 | t _{CK(AVG)} | | Reserved | ns | 1, 2, 3, 4, 9 |
| | CWL = 5,6,7 | t _{CK(AVG)} | | Reserved | ns | 4 |
| CL = 11 | CWL = 8 | t _{CK(AVG)} | 1.25 | <1.5 | ns | 1, 2, 3, 4, 9 |
| | CWL = 9 | t _{CK(AVG)} | | Reserved | ns | 1, 2, 3, 4 |
| CL = 12 CWL = 5,6,7,8 | | t _{CK(AVG)} | | Reserved | ns | 4 |
| CL = 12 | | t _{CK(AVG)} | | Reserved | ns | 1,2,3,4 |
| Cl = 12 | CWL = 5,6,7,8 | t _{CK(AVG)} | | Reserved | ns | 4 |
| CL = 13 $CWL = 9$ | | t _{CK(AVG)} | 1.07 | <1.25 | ns | 1, 2, 3 |
| Supported CL Settings | | | 5, 6, | n _{CK} | | |
| Sup | ported CWL Set | tings | | 5, 6, 7, 8, 9 | n _{CK} | |



DDR3-2133 Speed Bins

FFor specific Notes See "Speed Bin table Notes" on page 31.

| - | Speed Bin | - | D | DR3-2133N | | |
|---------|--|------------------------|-------|-----------------------|-----------------|----------------|
| | CL - nRCD - nRP | 1 | | 14-14-14 | Unit | Note |
| F | Parameter | Symbol | min | max | | |
| | read command to | t _{AA} | 13.09 | 20.0 | ns | |
| | first data | 5AA | 15.09 | 20.0 | 113 | |
| | ternal read or write delay time | $t_{\!\!	ext{RCD}}$ | 13.09 | _ | ns | |
| | ommand period | t_{RP} | 13.09 | _ | ns | |
| | RE command period | | 33.0 | 9 * tREFI | ns | |
| | to ACT or PRE | <i>t</i> _{RC} | 46.09 | - | ns | |
| con | nmand period CWL = 5 | | | Danasa | nc | 1 2 2 4 10 |
| CL = 5 | CWL = 5 CWL = 6,7,8,9,10 | t _{CK(AVG)} | | Reserved | ns | 1, 2, 3, 4, 10 |
| | CWL = 0,7,8,9,10 CWL = 5 | t _{CK(AVG)} | 2.5 | Reserved 3.3 | ns ns | 1, 2, 3, 10 |
| CL = 6 | CWL = 5 CWL = 6 | t _{CK(AVG)} | | | ns | 1, 2, 3, 10 |
| CL = 0 | CWL = 0 CWL = 7,8,910 | t _{CK(AVG)} | | Reserved | ns | 1, 2, 3, 4, 10 |
| | CWL = 7,0,510 $CWL = 5$ | t _{CK(AVG)} | | Reserved Reserved | ns | 4 |
| | CWL = 6 | CK(AVG) | 1.875 | < 2.5 | ns | 1, 2, 3, 10 |
| CL = 7 | CWL = 7 | t _{CK(AVG)} | | Reserved | ns | 1, 2, 3, 4, 10 |
| | CWL = 8,9,10 | t _{CK(AVG)} | | Reserved | ns | 4 |
| | CWL = 5 | CK(AVG) | | Reserved | ns | 4 |
| | CWL = 6 | t _{CK(AVG)} | 1.875 | < 2.5 | ns | 1, 2, 3, 10 |
| CL = 8 | CWL = 7 | CK(AVG) | | Reserved | ns | 1, 2, 3, 4, 10 |
| | CWL = 8,9,10 | t _{CK(AVG)} | | Reserved | ns | 4 |
| | CWL = 5, 6 | t _{CK(AVG)} | | Reserved | ns | 4 |
| CL = 9 | CWL = 7 | t _{CK(AVG)} | 1.5 | <1.875 | ns | 1, 2, 3, 10 |
| CL = 9 | CWL = 8 | t _{CK(AVG)} | | Reserved | ns | 1, 2, 3, 4, 10 |
| | CWL = 9,10 | t _{CK(AVG)} | | Reserved | ns | 4 |
| | CWL = 5, 6 | t _{CK(AVG)} | | Reserved | ns | 4 |
| | CWL = 7 | t _{CK(AVG)} | 1.5 | <1.875 | ns | 1, 2, 3, 10 |
| CL = 10 | | t _{CK(AVG)} | | Reserved | ns | 1, 2, 3, 4, 10 |
| | CWL = 9 | t _{CK(AVG)} | | Reserved | ns | 1, 2, 3, 4, 10 |
| | CWL = 10 | t _{CK(AVG)} | | Reserved | ns | 4 |
| | CWL = 5,6,7 | t _{CK(AVG)} | | Reserved | ns | 4 |
| CL = 11 | CWL = 8 | t _{CK(AVG)} | 1.25 | <1.5 | ns | 1, 2, 3, 10 |
| | CWL = 9 | t _{CK(AVG)} | | Reserved | ns | 1, 2, 3, 4, 10 |
| | CWL = 10 | ^t CK(AVG) | | Reserved | ns | 1, 2, 3, 4 |
| CL = 12 | CWL = 5,6,7,8 | t _{CK(AVG)} | | Reserved | ns | 4 |
| | CWL = 9 | t _{CK(AVG)} | | Reserved | ns | 1, 2, 3, 4, 10 |
| | CWL = 10 | t _{CK(AVG)} | | Reserved | ns | 1, 2, 3, 4 |
| GI 45 | CWL = 5,6,7,8 | t _{CK(AVG)} | | Reserved | ns | 4 |
| CL = 13 | CWL = 9 | t _{CK(AVG)} | 1.07 | <1.25 | ns | 1, 2, 3, 4 |
| | CWL = 10 | t _{CK(AVG)} | | Reserved | | 1, 2, 3, 4 |
| CL = 14 | CWL = 5,6,7,8,9 | t _{CK(AVG)} | | Reserved | ns | 4 |
| | CWL = 10 | t _{CK(AVG)} | 0.935 | <1.07 | ns | 1, 2, 3 |
| | Supported CL Setting apported CWL Setting | | | 9, 10, 11, 12, 13, 14 | n _{CK} | |
| St | apported CWL Settir | iys | 5, | 6, 7, 8, 9, 10 | n _{CK} | |



Speed Bin Table Notes

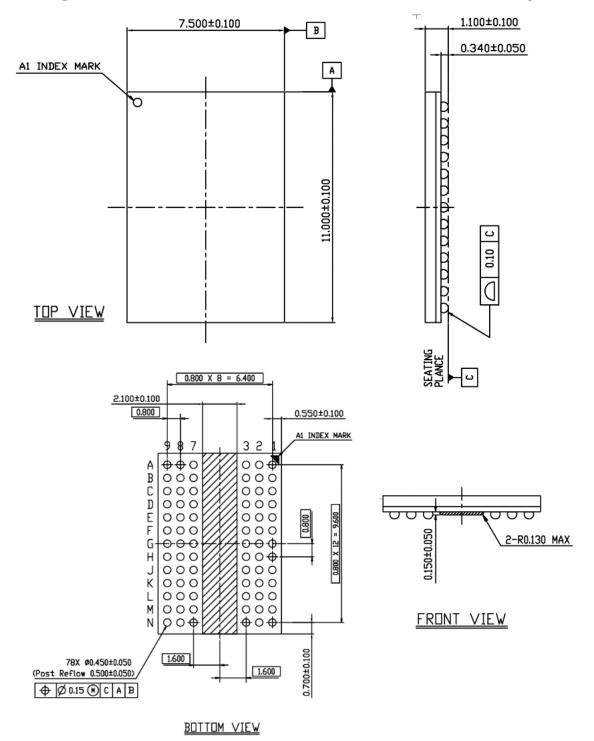
Absolute Specification (T_{OPER} ; $V_{DDO} = V_{DD} = 1.5V +/- 0.075 V$);

- The CL setting and CWL setting result in tCK(AVG).MIN and tCK(AVG).MAX requirements. When making a selection of tCK(AVG), both need to be fulfilled: Requirements from CL setting as well as requirements from CWL setting.
- 2. tCK(AVG).MIN limits: Since CAS Latency is not purely analog data and strobe output are synchronized by the DLL all possible intermediate frequencies may not be guaranteed. An application should use the next smaller JEDEC standard tCK(AVG) value (3.0, 2.5, 1.875, 1.5, or 1.25 ns) when calculating CL [nCK] = tAA [ns] / tCK(AVG) [ns], rounding up to the next 'Supported CL', where tCK(AVG) = 3.0 ns should only be used for CL = 5 calculation.
- 3. tCK(AVG).MAX limits: Calculate tCK(AVG) = tAA.MAX / CL SELECTED and round the resulting tCK(AVG) down to the next valid speed bin (i.e. 3.3ns or 2.5ns or 1.875 ns or 1.25 ns). This result is tCK(AVG).MAX corresponding to CL SELECTED.
- 4. 'Reserved' settings are not allowed. User must program a different value.
- 5. 'Optional' settings allow certain devices in the industry to support this setting, however, it is not a mandatory feature. Refer to SK Hynix DIMM data sheet and/or the DIMM SPD information if and how this setting is supported.
- 6. Any DDR3-1066 speed bin also supports functional operation at lower frequencies as shown in the table which are not subject to Production Tests but verified by Design/Characterization.
- 7. Any DDR3-1333 speed bin also supports functional operation at lower frequencies as shown in the table which are not subject to Production Tests but verified by Design/Characterization.
- 8. Any DDR3-1600 speed bin also supports functional operation at lower frequencies as shown in the table which are not subject to Production Tests but verified by Design/Characterization.
- 9. Any DDR3-1866 speed bin also supports functional operation at lower frequencies as shown in the table which are not subject to Production Tests but verified by Design/Characterization.
- 10. Any DDR3-2133 speed bin also supports functional operation at lower frequencies as shown in the table which are not subject to Production Tests but verified by Design/Characterization.
- 11. SK Hynix DDR3 SDRAM devices supporting optional down binning to CL=7 and CL=9, and tAA/tRCD/tRP must be 13.125 ns or lower. SPD settings must be programmed to match. For example, DDR3-1333H devices supporting down binning to DDR3-1066F should program 13.125 ns in SPD bytes for tAAmin (Byte 16), tRCDmin (Byte 18), and tRPmin (Byte 20). DDR3-1600K devices supporting down binning to DDR3-1333H or DDR3-1600F should program 13.125 ns in SPD bytes for tAAmin (Byte 16), tRCDmin (Byte 18), and tRPmin (Byte 20). Once tRP (Byte 20) is programmed to 13.125ns, tRCmin (Byte 21,23) also should be programmed accordingly. For example, 49.125ns (tRASmin + tRPmin = 36 ns + 13.125 ns) for DDR3-1333H and 48.125ns (tRASmin + tRPmin = 35 ns + 13.125 ns) for DDR3-1600K.
- 12. DDR3 800 AC timing apply if DRAM operates at lower than 800 MT/s data rate.
- 13. For CL5 support, refer to DIMM SPD information. DRAM is required to support CL5. CL5 is not mandatory in SPD coding.
- 14. SK Hynix DDR3 SDRAM devices supporting optional down binning to CL=11, CL=9 and CL=7, tAA/tRCD/tRPmin must be 13.125ns. SPD setting must be programed to match. For example, DDR3-1866M devices supporting down binning to DDR3-1600K or DDR3-1333H or 1066F should program 13.125ns in SPD bytes for tAAmin(byte 16), tRCDmin(byte 18) and tRPmin(byte 20) is programmed to 13.125ns, tRCmin(byte 21,23) also should be programmed accordingly. For example, 47.125ns (tRASmin + tRPmin = 34ns +13.125ns)



Package Dimensions

Package Dimension(x8): 78Ball Fine Pitch Ball Grid Array Outline





Package Dimension(x16): 96Ball Fine Pitch Ball Grid Array Outline

